

Search Notes

Application/Control No.

09/741,631

Examiner

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Applicant(s)/Patent under
Reexamination

PATRICK, CHRISTOPHER

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	343	11/1/2007	TW
701	207	11/1/2007	TW
	UPDATED		
375	141, 150	11/1/2007	TW
342	378	11/1/2007	TW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	141, 150	11/1/2007	TW
375	343	11/1/2007	TW
342	378	11/1/2007	TW
701/207		11/1/2007	TW

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST - USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB, see attached search report	11/1/2007	TW
ODP- searched and reviewed.	11/1/2007	TW
Inventor search - Patrick with Christopher	11/1/2007	TW
IEEEExplor - author search - Patrick C.	11/1/2007	TW